

N-Channel MOSFET

General Description

The WSP6024 is the highest performance trench N-ch MOSFETs with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSP6024meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Product Summery

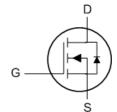
BVDSS	RDSON	ID		
60V	8 m Ω	15A		

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOP-8 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	15	Α
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	9.6	Α
I _{DM} ^a	Pulsed Drain Current ²	43	Α
EASb	Single Pulse Avalanche Energy ³	81	mJ
l _{AS} ^b	Avalanche Current	16	А
P _D @T _A =25°C	Total Power Dissipation⁴	1.78	W
T _{STG}	Storage Temperature Range	-55 to 150	$^{\circ}$
TJ	Operating Junction Temperature Range	150	$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA} c	Thermal Resistance Junction-ambient ¹		72	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		1.2	°C/W

Note a : Pulse width limited by max. junction temperature.

Note b: UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature T_i=25°C).

Note c : Surface Mounted on 1in² pad area.

N-Channel MOSFET

Electrical Characteristics (T_J =25 $\,^{\circ}$ C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃ , I _D =1mA		0.044		V/°C	
В	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =13A		8	10	mO	
R _{DS(ON)}	Static Dialit-Source Off-Resistance	V _{GS} =4.5V , I _D =8A		11	13.7	mΩ	
V _{GS(th)}	Gate Threshold Voltage	\/ -\/ -250\	1.0	2.0	3.0	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-4.6		mV/℃	
,	Drain Source Leakage Current	V _{DS} =60V , V _{GS} =0V , T _J =25℃			1		
I _{DSS}	Drain-Source Leakage Current	V_{DS} =60 V , V_{GS} =0 V , T_J =55 $^{\circ}{\rm C}$			100	uA	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA	
Q_{g}	Total Gate Charge (10V)			25.4			
Q_gs	Gate-Source Charge	V_{DS} =30V , V_{GS} =10V , I_{D} =6A		4.6		nC	
Q_{gd}	Gate-Drain Charge			3.8			
$T_{d(on)}$	Turn-On Delay Time			15			
Tr	Rise Time	V _{DD} =30V , V _{GEN} =10V ,		7		20	
T _{d(off)}	Turn-Off Delay Time	$R_G=6\Omega I_D=1A$,RL= 30Ω		34		ns	
T _f	Fall Time			30			
C _{iss}	Input Capacitance			1500			
C _{oss}	Output Capacitance	V_{DS} =30V , V_{GS} =0V , f=1MHz		280		pF	
C _{rss}	Reverse Transfer Capacitance			40			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1.3	V
t _{rr}	Reverse Recovery Time			30		nS
Q _{rr}	Reverse Recovery Charge	IF=6.0A , dI/dt=100A/ μ s , T $_{ m J}$ =25 $^{\circ}{ m C}$		29		nC

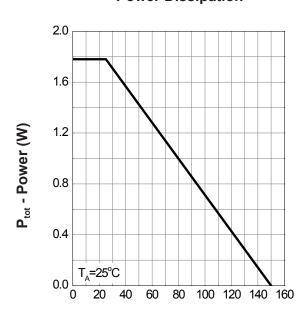
Note d : Pulse test ; pulse width≤300ms, duty cycle≤2%.

Note e: Guaranteed by design, not subject to production testing.



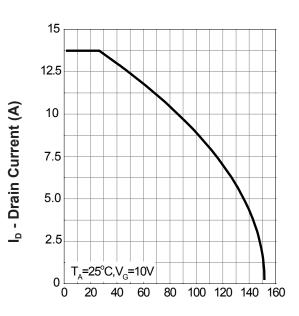
Typical Characteristics

Power Dissipation



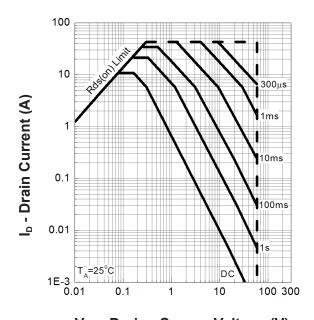
T_i - Junction Temperature (°C)

Drain Current



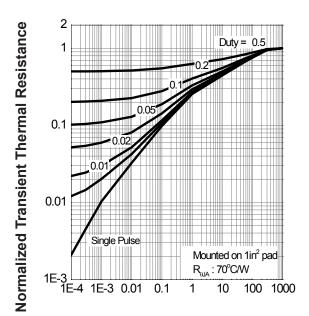
T_i - Junction Temperature (°C)

Safe Operation Area



V_{DS} - Drain - Source Voltage (V)

Thermal Transient Impedance

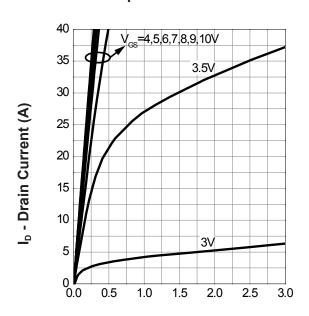


Square Wave Pulse Duration (sec)

Fig5. Typical Source-Drain Diode Forward Voltage

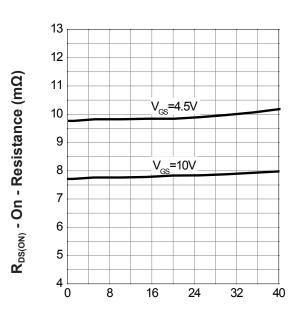


Output Characteristics



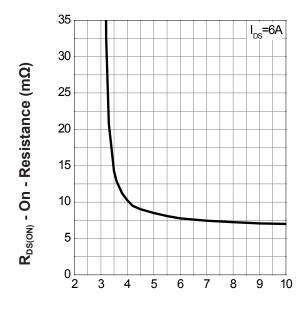
V_{DS} - Drain - Source Voltage (V)

Drain-Source On Resistance



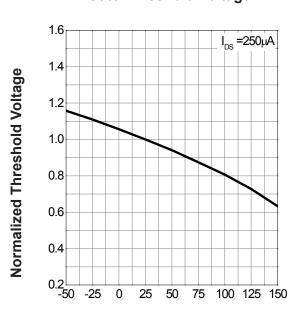
I_D - Drain Current (A)

Gate-Source On Resistance



V_{GS} - Gate - Source Voltage (V)

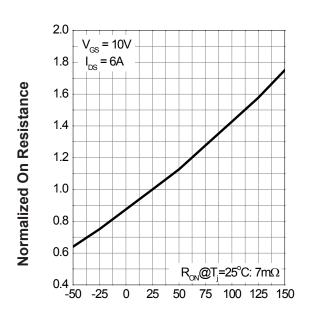
Gate Threshold Voltage



T_j - Junction Temperature (°C)

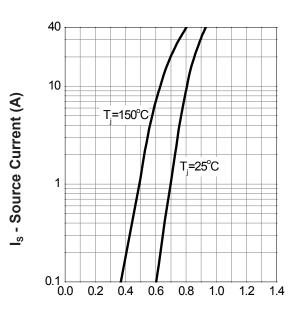


Drain-Source On Resistance



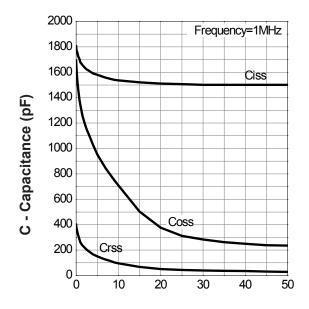
T_i - Junction Temperature (°C)

Source-Drain Diode Forward



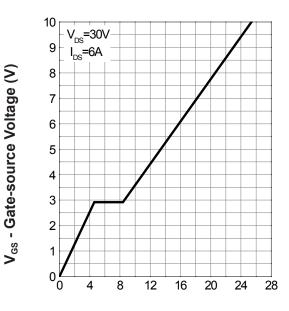
V_{SD} - Source - Drain Voltage (V)

Capacitance



V_{DS} - Drain-Source Voltage (V)

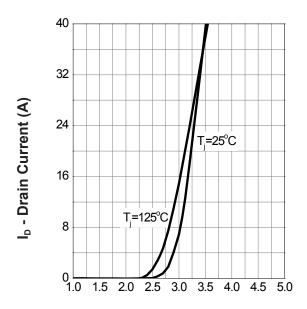
Gate Charge



Q_G - Gate Charge (nC)



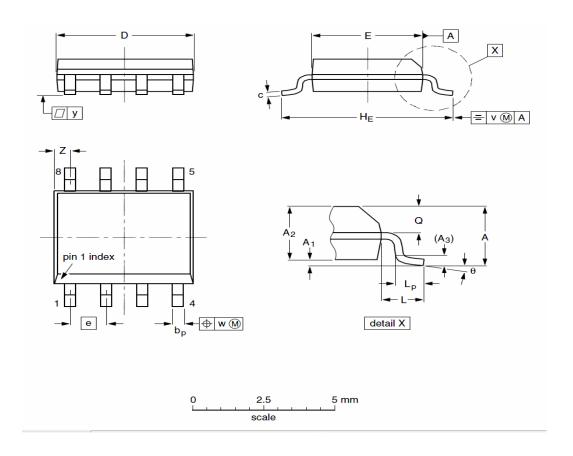
Transfer Characteristics



V_{GS} - Gate-Source Voltage (V)



SOP8 Package Outline Data



DIMENSIONS (unit : mm)

Symbol	Min	Тур	Max	Symbol	Min	Тур	Max
Α		1.75		A ₁	0.10	0.18	0.25
A_2	1.25	1.35	1.45	A ₃		0.25	1
b _p	0.36	0.42	0.49	С	0.19	0.22	0.25
D	4.80	4.92	5.00	E	3.80	3.90	4.00
е		1.27		HE	5.80	5.98	6.20
L		1.05		Lp	0.40	0.68	1.00
Q	0.60	0.65	0.70	v		0.25	
w		0.25	1	у		0.10	1
Z	0.30	0.50	0.70	θ	0°		8°



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